



ACE636B

Common Drain Dual N-Channel Enhancement Mode Field Effect

Description

Advanced trench process technology. High Density Cell Design For Ultra Low On-Resistance. High Power and Current handing capability. Fully Characterized Avalanche Voltage and Current. Small Surface Mount Package

Features

- V_{DS} 20V, I_D =6A
- $R_{DS(ON)}$ =22m Ω @ V_{GS} =4.5V
- $R_{DS(ON)}$ =30m Ω @ V_{GS} =2.5V
- For a single mosfet

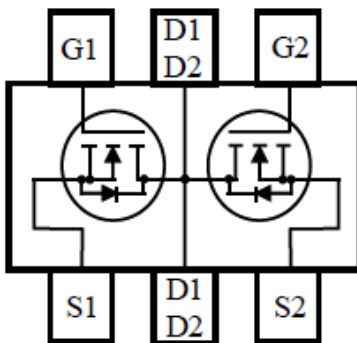
Absolute Maximum Ratings

Parameter	Symbol	Max	Unit
Drain-Source Voltage	V_{DSS}	20	V
Gate-Source Voltage	V_{GSS}	± 12	V
Drain Current (Note 1), Continuous	I_D	6	A
Total Power Dissipation (Note1)	P_D	650	mW
Operating and Storage Temperature Range	T_J/T_{STG}	-55/150	$^{\circ}C$

Note: Mounted on FR-4 PCB, 1 inch x 0.85 inch x 0.062 inch.

Packaging Type

SOT-23-6L





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Ordering information

ACE636B XX + H

<input type="checkbox"/>	Halogen - free
<input type="checkbox"/>	Pb - free
<input type="checkbox"/>	GM : SOT-23-6L

Electrical Characteristics

$T_A=25^{\circ}\text{C}$, unless otherwise noted.

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Off characteristics (Note 2)						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =250 uA	20			V
Gate Leakage Current	I _{GSS}	V _{DS} =0V, V _{GS} =±12V			±100	uA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =20V, V _{GS} =0V			1	uA
On characteristics						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _{DS} =250uA	0.6		1.2	V
Forward Transconductance	G _{FS}	V _{DS} =10V, I _D =6A	7	13		S
Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} =4.5V, I _D =6A		22	50	mΩ
		V _{GS} =2.5V, I _D =5.2A		30	65	
Drain-Source Diode Characteristics And Maximum Ratings						
Diode Forward Voltage	V _{SD}	I _S =2A, V _{GS} =0V	0.5	0.77	1	V
Switching characteristics						
Turn-On Delay Time	td(on)	R _G =6Ω, V _{DD} =10V, V _{GEN} =4.5V, I _D =1A		18		nS
Turn-Off Delay Time	td(off)			25		
Dynamic characteristics						
Input Capacitance	Ciss	V _{GS} =0V, V _{DS} =8V, f=1MHz		562		pF
Output Capacitance	Coss			106		
REVERSE Transfer Capacitance	Crss			75		
Total Gate Charge	Q _G	V _{DS} =10V, I _D =6A, V _{GS} =4.5V		4.86		nC
Gate-Source Charge	Q _{GS}			0.92		
Gate-Drain	Q _{GD}			1.4		

Note: 2. Short duration test pulse used to minimize self-heating effect.



Typical Performance Characteristics

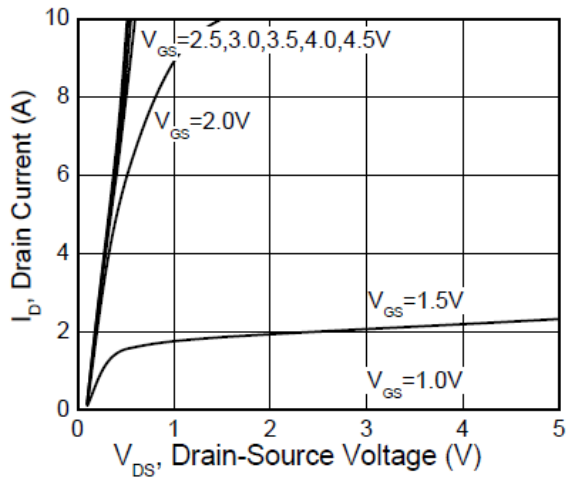


Figure 1. Output Characteristics

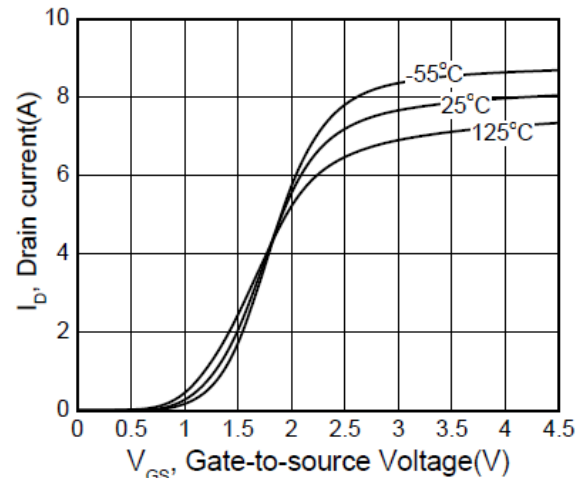


Figure 2. Transfer Characteristics

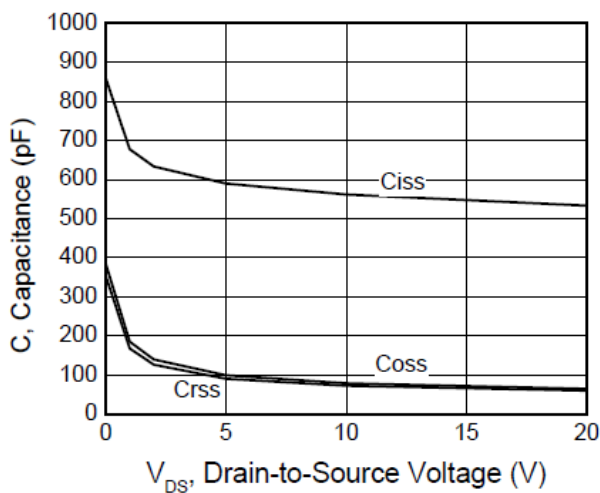


Figure 3. Capacitance

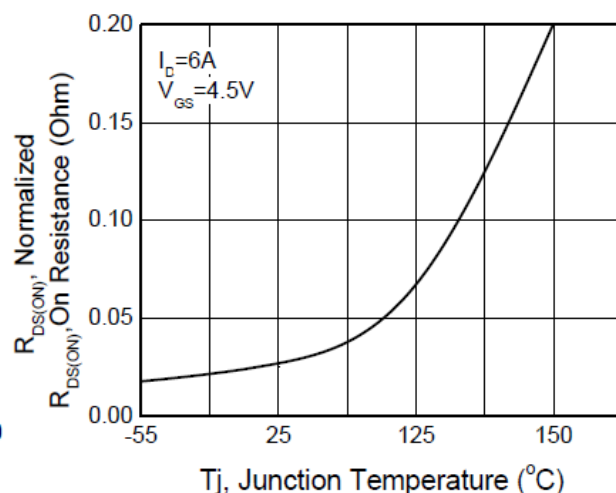


Figure 4. On Resistance Vs. Temperature

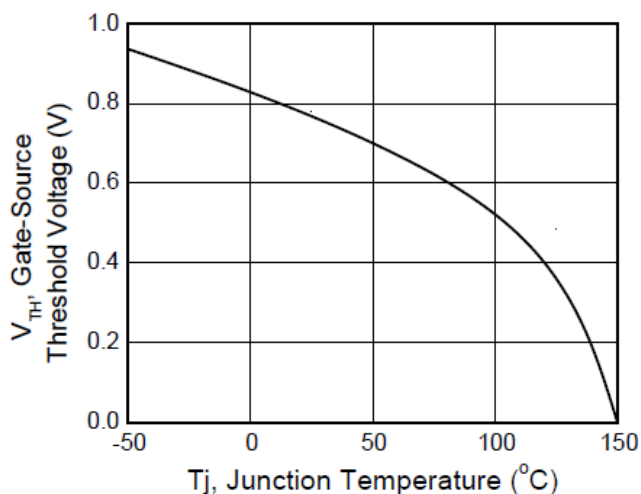


Figure 5. Gate Threshold Vs. Temperature

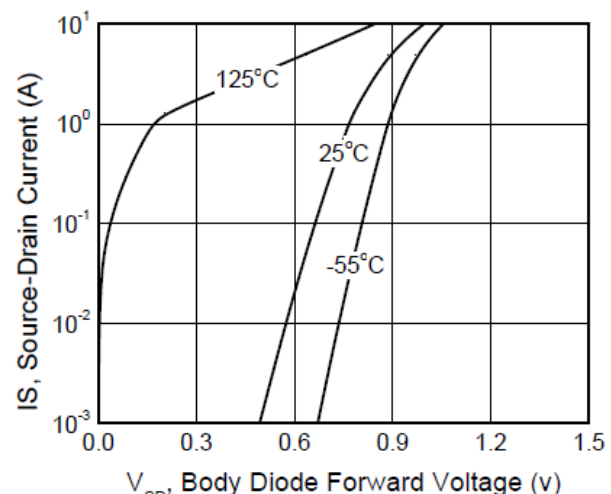


Figure 6. Body Diode Forward Voltage
Vs. Source Current

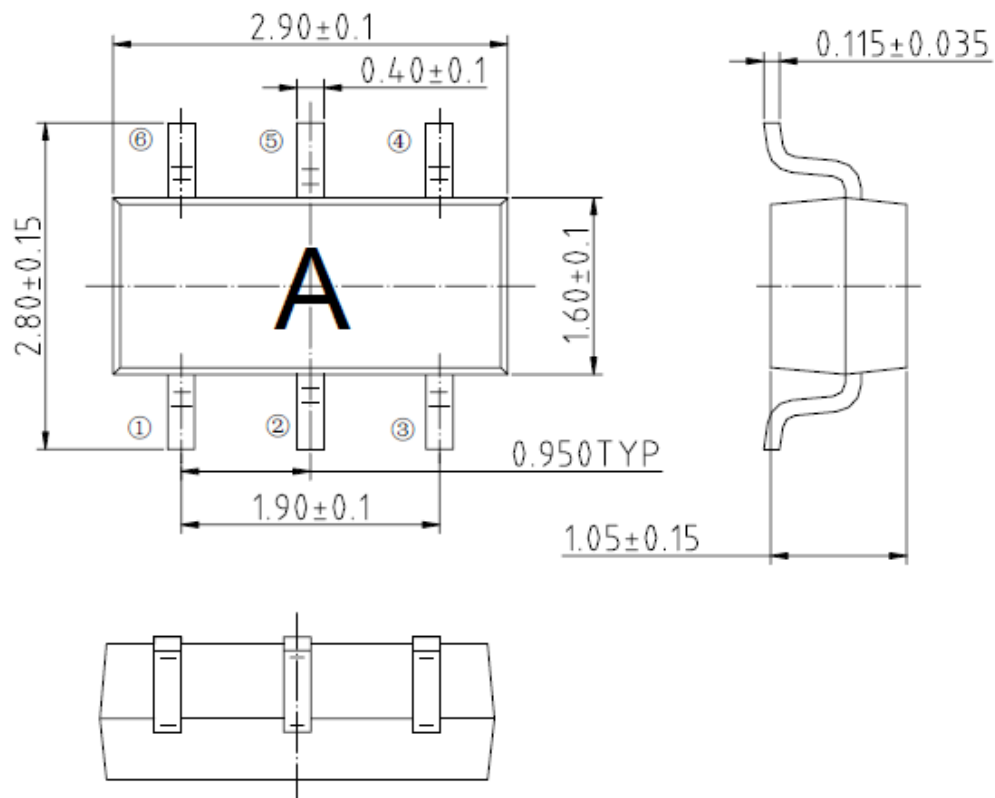


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Packing Information

SOT-23-6L



Unit: mm



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Notes

ACE does not assume any responsibility for use as critical components in life support devices or systems without the express written approval of the president and general counsel of ACE Electronics Co., LTD. As sued herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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